

Rectifier Diodes

Avalanche Diodes

$$V_{RRM} = 800 - 1800 \text{ V}$$

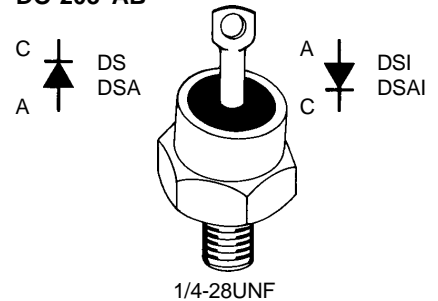
$$I_{F(RMS)} = 160 \text{ A}$$

$$I_{F(AV)M} = 110 \text{ A}$$

V_{RSM} V	$V_{(BR)min}$ ① V	V_{RRM} V	Anode on stud	Cathode on stud
900	-	800	DS 75-08B	DSI 75-08B
1300	-	1200	DS 75-12B	DSI 75-12B
1300	1300	1200	DSA 75-12B	DSAI 75-12B
1700	1760	1600	DSA 75-16B	DSAI 75-16B
1900	1950	1800	DSA 75-18B	DSAI 75-18B

① Only for Avalanche Diodes

DO-203 AB



A = Anode C = Cathode

Symbol	Test Conditions	Maximum Ratings	
$I_{F(RMS)}$ $I_{F(AV)M}$	$T_{(vj)} = T_{(vj)m}$ $T_{case} = 100^\circ\text{C}; 180^\circ \text{ sine}$	160 110	A A
P_{RSM}	DSA(I) types, $T_{(vj)} = T_{(vj)m}$, $t_p = 10 \mu\text{s}$	20	kW
I_{FSM}	$T_{(vj)} = 45^\circ\text{C}; V_R = 0$ $t = 10 \text{ ms (50 Hz), sine}$	1400	A
	$t = 8.3 \text{ ms (60 Hz), sine}$	1500	A
I^2t	$T_{(vj)} = T_{(vj)m}$ $V_R = 0$ $t = 10 \text{ ms (50 Hz), sine}$	1250	A
	$t = 8.3 \text{ ms (60 Hz), sine}$	1310	A
$T_{(vj)}$ $T_{(vj)m}$ T_{stg}	$T_{(vj)} = 45^\circ\text{C}$ $V_R = 0$ $t = 10 \text{ ms (50 Hz), sine}$	9800	A ² s
	$t = 8.3 \text{ ms (60 Hz), sine}$	9450	A ² s
$T_{(vj)}$ $T_{(vj)m}$ T_{stg}	$T_{(vj)} = T_{(vj)m}$ $V_R = 0$ $t = 10 \text{ ms (50 Hz), sine}$	7820	A ² s
	$t = 8.3 \text{ ms (60 Hz), sine}$	7210	A ² s
M_d	Mounting torque	3.5-4.5 31-40	Nm lb.in.
Weight		21	g

Features

- International standard package, JEDEC DO-203 AB (DO-5)
- Planar glassivated chips

Applications

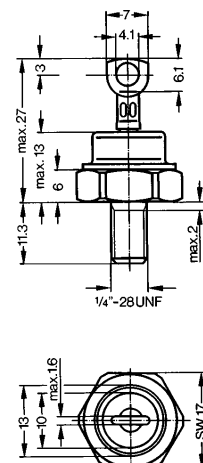
- High power rectifiers
- Field supply for DC motors
- Power supplies

Advantages

- Space and weight savings
- Simple mounting
- Improved temperature and power cycling
- Reduced protection circuits

Dimensions in mm (1 mm = 0.0394")

Symbol	Test Conditions	Characteristic Values	
I_R	$T_{(vj)} = T_{(vj)m}$; $V_R = V_{RRM}$	≤ 6	mA
V_F	$I_F = 150 \text{ A}; T_{(vj)} = 25^\circ\text{C}$	≤ 1.17	V
V_{T0}	For power-loss calculations only	0.75	V
r_T	$T_{(vj)} = T_{(vj)m}$	2	mΩ
R_{thJC}	DC current	0.5	K/W
R_{thJH}	DC current	0.9	K/W
d_s	Creepage distance on surface	4.05	mm
d_A	Strike distance through air	3.9	mm
a	Max. allowable acceleration	100	m/s ²



Data according to IEC 747-2

IXYS reserves the right to change limits, test conditions and dimensions

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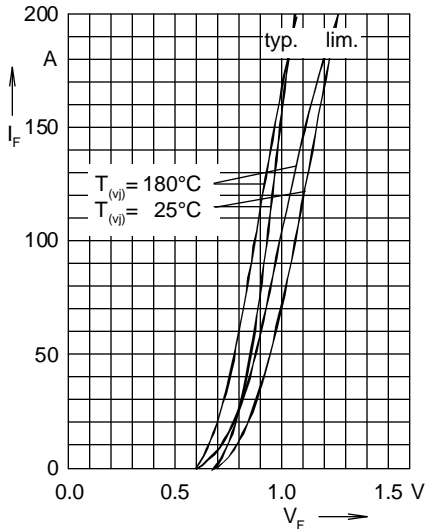


Fig. 1 Forward characteristics

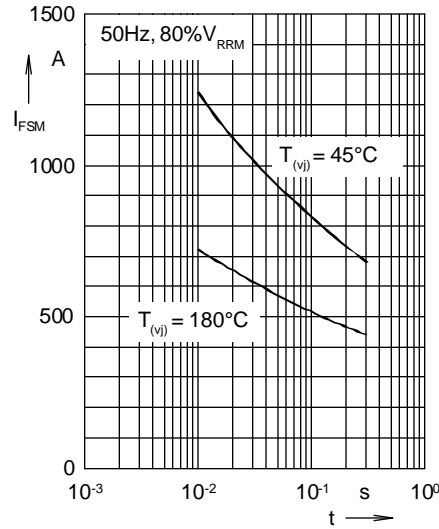


Fig. 2 Surge overload current
 I_{FSM} : Crest value, t : duration

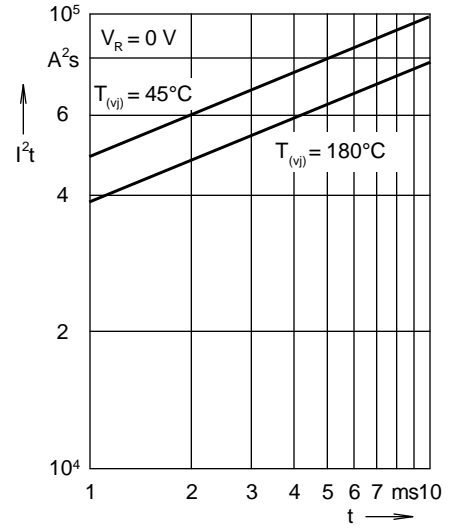


Fig. 3 I^2t versus time (1-10 ms)

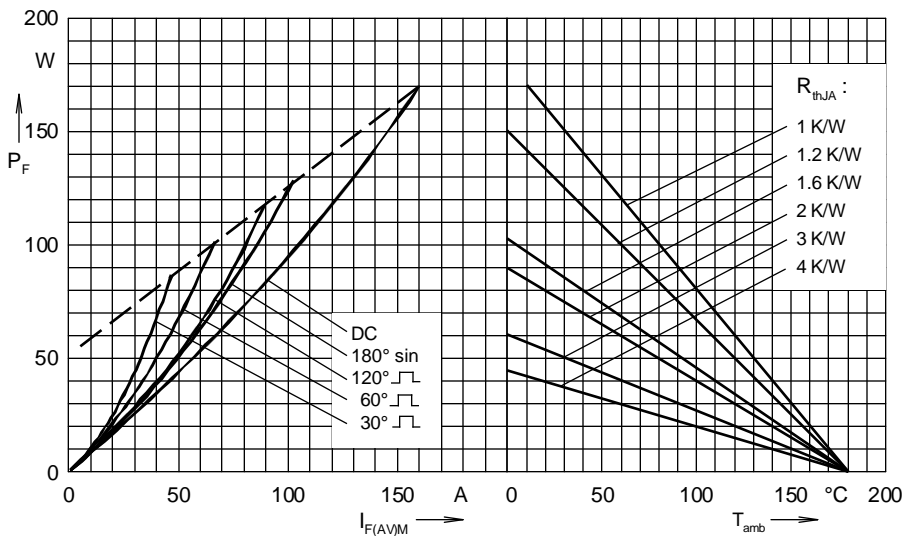


Fig. 4 Power dissipation versus forward current and ambient temperature

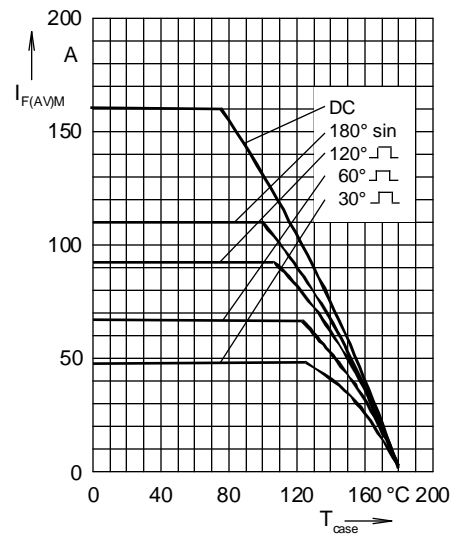


Fig. 5 Max. forward current at case temperature

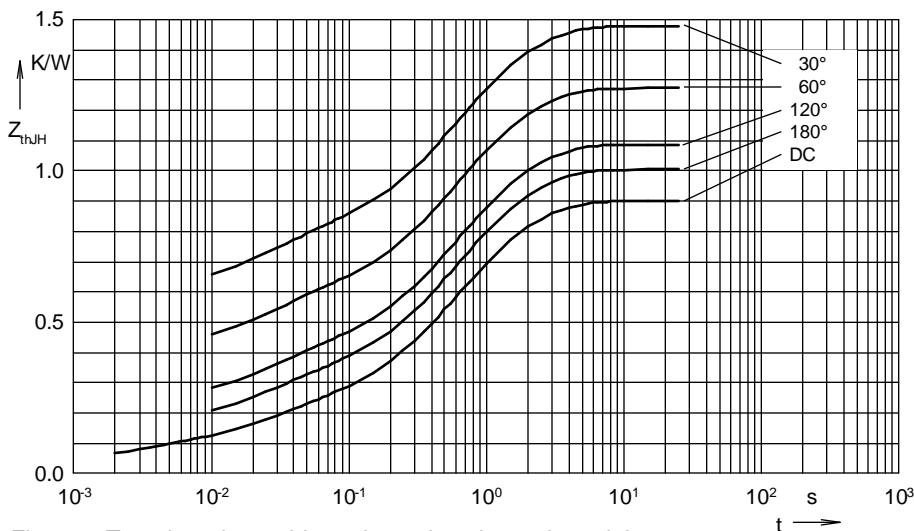


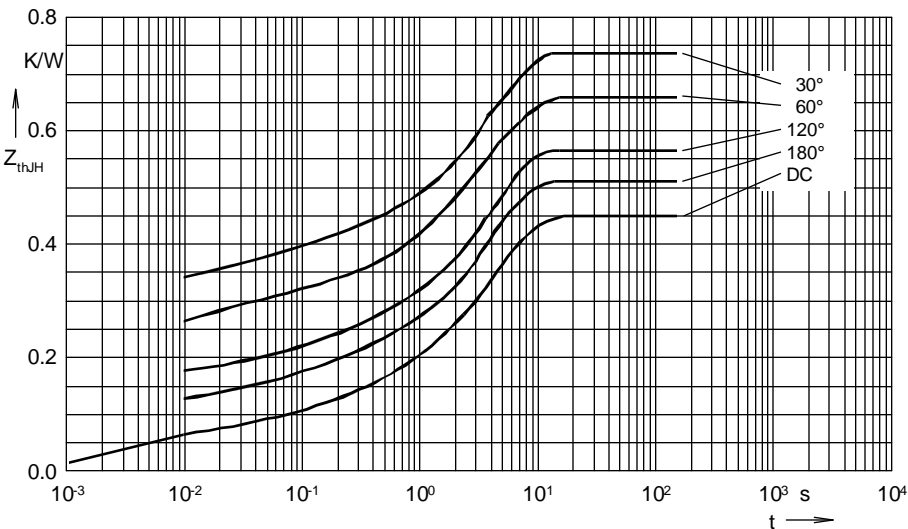
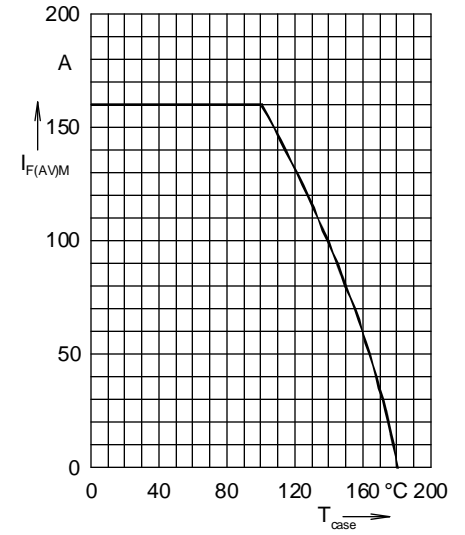
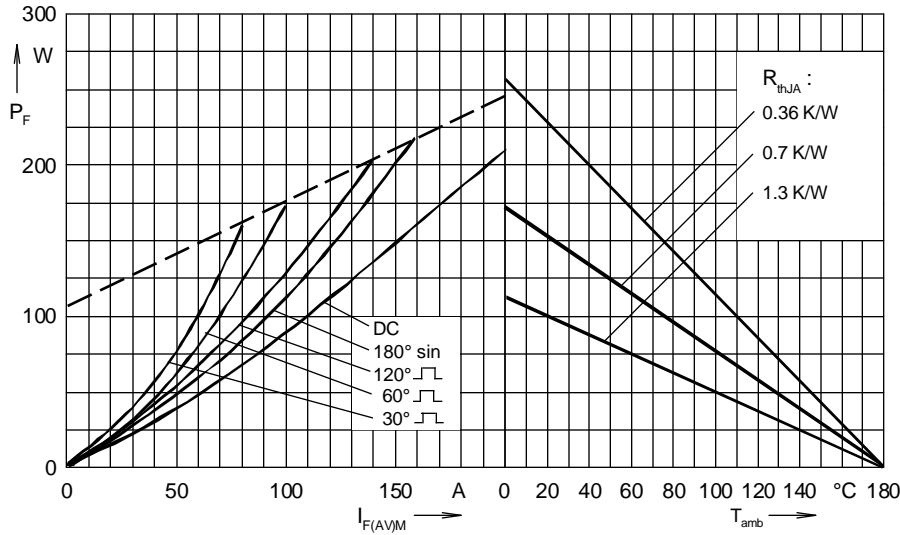
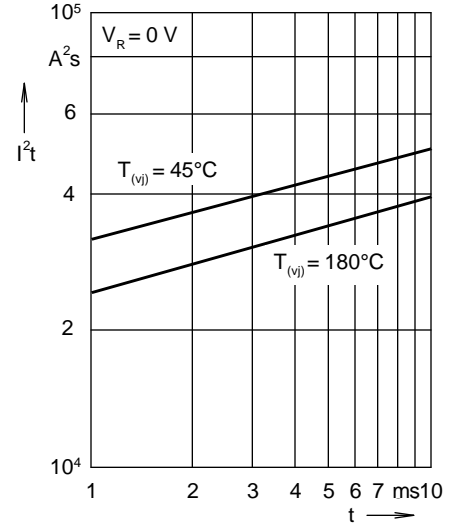
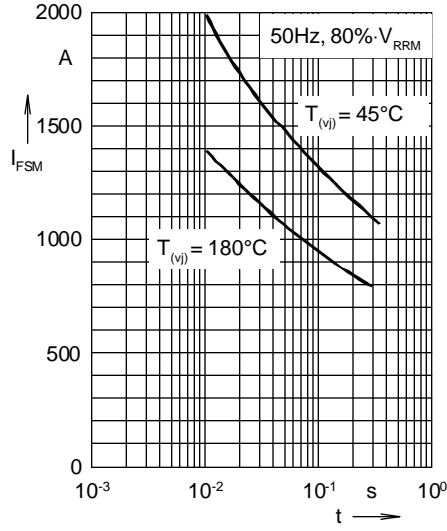
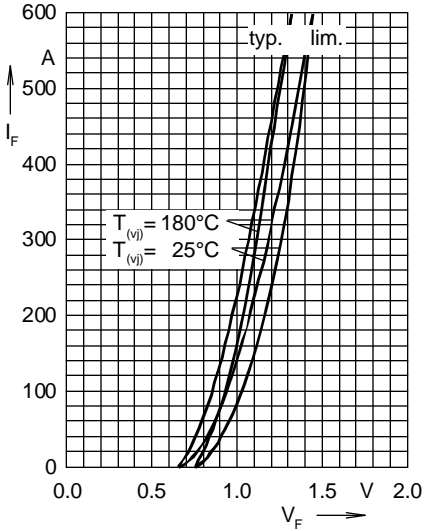
Fig. 6 Transient thermal impedance junction to heatsink

R_{thJH} for various conduction angles d :

d	R_{thJH} (K/W)
DC	0.900
180°	1.028
120°	1.085
60°	1.272
30°	1.476

Constants for Z_{thJH} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.0731	0.0015
2	0.1234	0.0237
3	0.4035	0.4838
4	0.3000	1.5



R_{thJH} for various conduction angles d :

d	R_{thJH} (K/W)
DC	0.45
180°	0.516
120°	0.567
60°	0.660
30°	0.733

Constants for Z_{thJH} calculation:

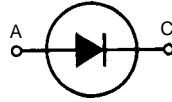
i	R_{thi} (K/W)	t_i (s)
1	0.06713	0.003
2	0.06242	0.094
3	0.22045	3.846
4	0.10	3.2

Fig. 6 Transient thermal impedance junction to heatsink

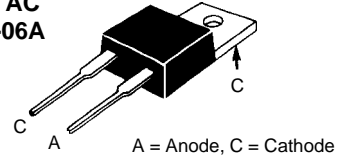
Fast Recovery Epitaxial Diode (FRED)

DSEI 8
 $I_{FAVM} = 8 \text{ A}$
 $V_{RRM} = 600 \text{ V}$
 $t_{rr} = 35 \text{ ns}$

V_{RSM} V	V_{RRM} V	Type
640	600	DSEI 8-06A
640	600	DSEI 8-06AS

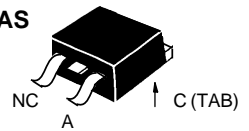


TO-220 AC
DSEI 8-06A



Symbol	Test Conditions	Maximum Ratings	
I_{FRMS}	$T_{VJ} = T_{VJM}$	16	A
$I_{FAVM} \star$	$T_C = 115^\circ\text{C}$; rectangular, $d = 0.5$	8	A
I_{FRM}	$t_p < 10 \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	130	A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	100	A
		110	A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	85	A
		95	A
$\int i^2 dt$	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	50	A^2s
		50	A^2s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	36	A^2s
		37	A^2s
T_{VJ}		-40...+150	$^\circ\text{C}$
T_{VJM}		150	$^\circ\text{C}$
T_{stg}		-40...+150	$^\circ\text{C}$
P_{tot}	$T_C = 25^\circ\text{C}$	50	W
M_d	Mounting torque with screw M3	0.45/4	Nm/lb.in.
	Mounting torque with screw M3.5	0.55/5	Nm/lb.in.
Weight		2	g

TO-263 AA
DSEI 8-06AS



A = Anode, C = Cathode, NC = No connection
TAB = Cathode

Features

- International standard package JEDEC TO-220 AC
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I_{RM} -values
- Soft recovery behaviour
- Epoxy meet UL 94V-0.

Applications

- Antiparallel diode for high frequency switching devices
- Anti saturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating and melting
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Advantages

- High reliability circuit operation
- Low voltage peaks for reduced protection circuits
- Low noise switching
- Low losses
- Operating at lower temperature or space saving by reduced cooling

Symbol	Test Conditions	Characteristic Values	
		typ.	max.
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$		20 μA
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		10 μA
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		1.5 mA
V_F	$I_F = 8 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$ $T_{VJ} = 25^\circ\text{C}$		1.3 V
			1.5 V
V_{T0}	For power-loss calculations only		0.98 V
r_T	$T_{VJ} = T_{VJM}$		28.7 $\text{m}\Omega$
R_{thJC}	0.5		2.5 K/W
R_{thCK}		K/W	
R_{thJA}		60 K/W	
t_{rr}	$I_F = 1 \text{ A}$; $-di/dt = 50 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	35	50 ns
I_{RM}	$V_R = 350 \text{ V}$; $I_F = 8 \text{ A}$; $-di_F/dt = 64 \text{ A}/\mu\text{s}$ $L \leq 0.05 \mu\text{H}$; $T_{VJ} = 100^\circ\text{C}$	2.5	2.8 A

$\star I_{FAVM}$ rating includes reverse blocking losses at T_{VJM} , $V_R = 0.8 V_{RRM}$, duty cycle $d = 0.5$
Data according to DIN/IEC 747

IXYS reserves the right to change limits, test conditions and dimensions

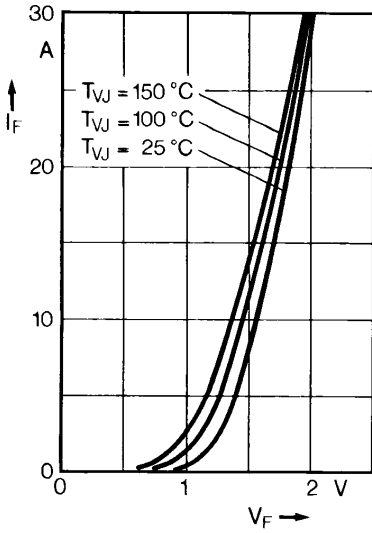


Fig. 1 Forward current versus voltage drop.

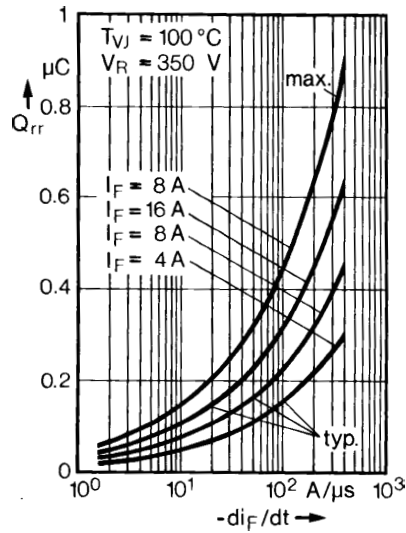


Fig. 2 Recovery charge versus $-di_F/dt$.

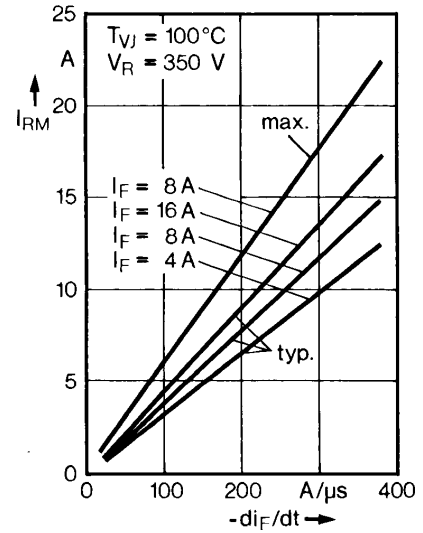


Fig. 3 Peak reverse current versus $-di_F/dt$.

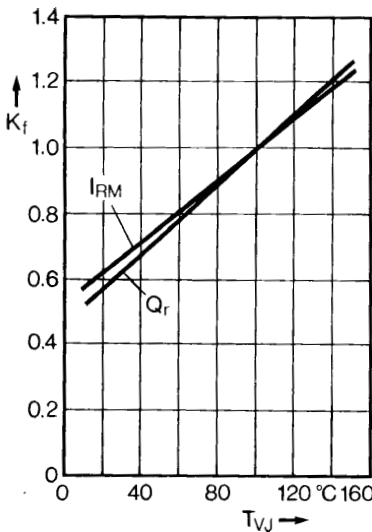


Fig. 4 Dynamic parameters versus junction temperature.

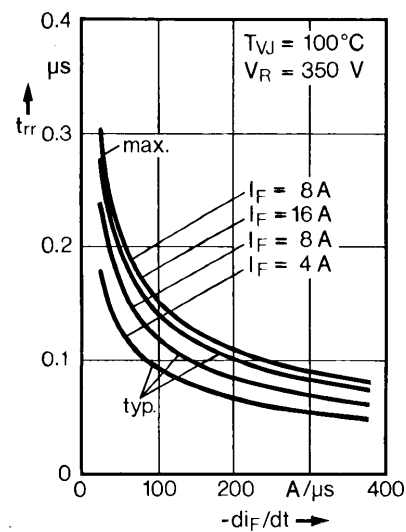


Fig. 5 Recovery time versus $-di_F/dt$.

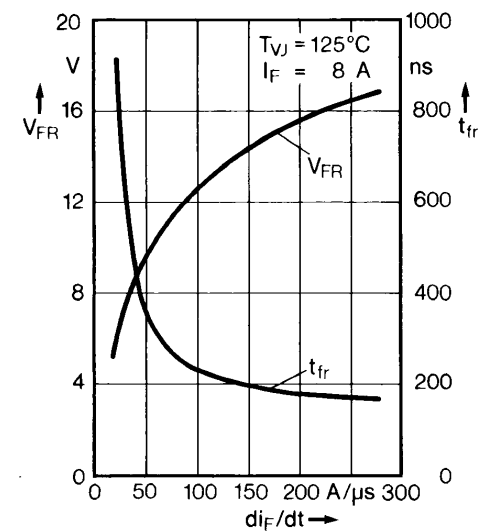


Fig. 6 Peak forward voltage versus $-di_F/dt$.

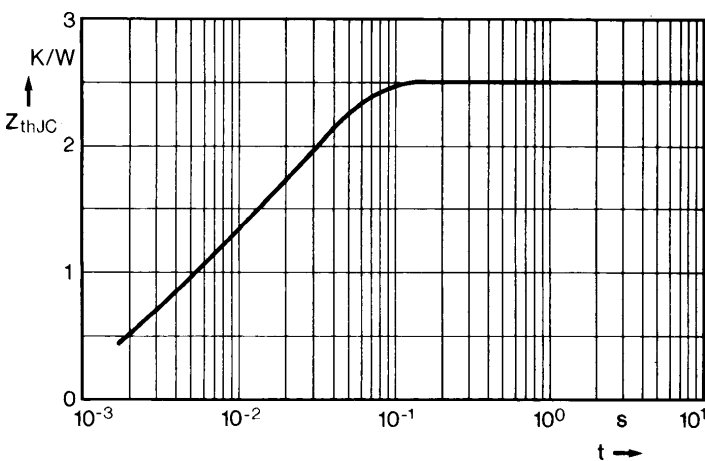
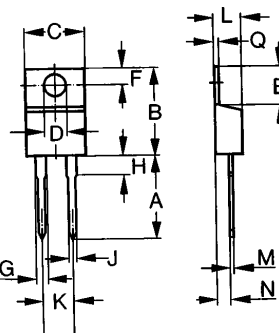


Fig. 7 Transient thermal impedance junction to case.

Dimensions TO-220 AC



Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	12.70	14.73	0.500	0.580
B	14.23	16.51	0.560	0.650
C	9.66	10.66	0.380	0.420
D	3.54	4.08	0.139	0.161
E	5.85	6.85	2.300	0.420
F	2.54	3.42	0.100	0.135
G	1.15	1.77	0.045	0.070
H	-	6.35	-	0.250
J	0.64	0.89	0.025	0.035
K	4.83	5.33	0.190	0.210
L	3.56	4.82	0.140	0.190
M	0.51	0.76	0.020	0.030
N	2.04	2.49	0.080	0.115
Q	0.64	1.39	0.025	0.055

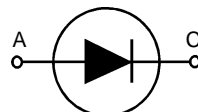
Dimension TO-263 AA see DSEI 19 page 17

Fast Recovery Exptaxial Diode (FRED)

$$I_{FRMS} = 75 \text{ A}$$

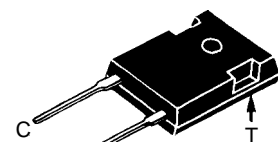
$$V_{RRM} = 1200 \text{ V}$$

$$t_{rr} = 40 \text{ ns}$$



V_{RSM}	V_{RRM}	Type
1200 V	1200 V	DSEI 120-12A

Symbol	Test Conditions	Maximum Ratings		
I_{FRMS}		75	A	
I_{FAVM}	$T_C = 92^\circ\text{C}$ (Note 1)	53	A	
I_{FRM}	$t_p < 10\mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	TBD	A	
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$;	$t = 10 \text{ ms}$ (50 Hz), sine	600	A
		$t = 8.3 \text{ ms}$ (60 Hz), sine	660	A
I_{FSM}	$T_{VJ} = 150^\circ\text{C}$;	$t = 10 \text{ ms}$ (50 Hz), sine	540	A
		$t = 8.3 \text{ ms}$ (60 Hz), sine	600	A
$\int j^2 dt$	$T_{VJ} = 45^\circ\text{C}$	$t = 10 \text{ ms}$ (50 Hz), sine	1800	A^2s
		$t = 8.3 \text{ ms}$ (60 Hz), sine	1800	A^2s
$\int j^2 dt$	$T_{VJ} = 150^\circ\text{C}$;	$t = 10 \text{ ms}$ (50 Hz), sine	1450	A^2s
		$t = 8.3 \text{ ms}$ (60 Hz), sine	1500	A^2s
T_{VJ}		-40...+150	$^\circ\text{C}$	
T_{VJM}		150	$^\circ\text{C}$	
T_{stg}		-40...+150	$^\circ\text{C}$	
P_{tot}	$T_C = 25^\circ\text{C}$	357	W	
M_d	Mounting torque with screw M3	0.45/4	Nm/lb.in.	
	Mounting torque with screw M3.5	0.55/5	Nm/lb.in.	
Weight		6	g	



TO-247 AD

A = Anode C = Cathode

Features

- Low I_{RM} values
- Planar passivated chips
- Soft recovery behavior
- Very short recovery time
- Extremely low switching losses
- Epoxy meets UL 94V-0
- International standard package JEDEC TO-247 AD

Applications

- Snubber diode
- Anti-saturation diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Induction heating and melting
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders
- Antiparallel diode for high frequency switching devices

Advantages

- Low losses
- Low noise switching
- Highly reliable circuit operation
- Low voltage peaks for reduced protection circuits
- Lower temperature operation
- Space saving by reduced cooling

Symbol	Test Conditions	Characteristic Values	
		Typ.	Max.
I_R	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ\text{C}$	3 mA
	$V_R = 0.8 V_{RRM}$	$T_{VJ} = 25^\circ\text{C}$	1.5 mA
	$V_R = 0.8 V_{RRM}$	$T_{VJ} = 125^\circ\text{C}$	20 mA
V_F	$I_F = 70\text{A}$	$T_{VJ} = 150^\circ\text{C}$	1.55 V
		$T_{VJ} = 25^\circ\text{C}$	1.8 V
V_{To}	For power-loss calculations only		1.16 V
r_F	$T_{VJ} = T_{VJM}$		4.16 m Ω
R_{thJC}		0.15	0.35 K/W
R_{thCK}			K/W
R_{thJA}			35 K/W
t_{rr}	$I_F = 1\text{A}$; $-di/dt = 200\text{A}/\mu\text{s}$; $V_R = 30\text{V}$; $T_{VJ} = 25^\circ\text{C}$	40	60 ns
I_{RM}	$I_F = 350\text{V}$; $I_F = 80\text{A}$; $-di_F/dt = 200\text{A}/\mu\text{s}$	16	21 A
			$L \leq 0.05 \mu\text{H}$

Fig. 1 Forward current versus voltage drop

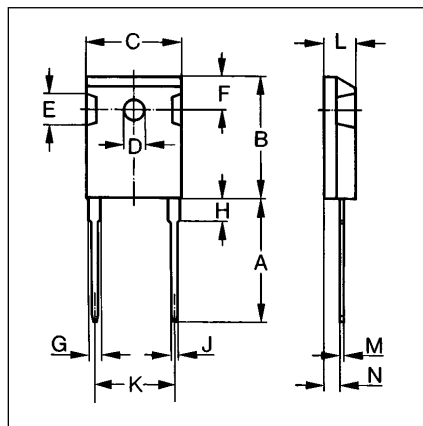
Fig. 2 Reverse recovery charge versus $-di_F/dt$.

Fig. 3 Peak reverse current versus $-di_F/dt$.

Fig. 4 Dynamic parameters versus junction temperature.

Fig. 5 Recovery time versus $-di_F/dt$.

Fig. 6 Peak forward voltage versus $-di_F/dt$.



Dimensions

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	19.81	20.32	0.780	0.800
B	20.80	21.46	0.819	0.845
C	15.75	16.26	0.610	0.640
D	3.55	3.65	0.140	0.144
E	4.32	5.49	0.170	0.216
F	5.4	6.2	0.212	0.244
G	1.65	2.13	0.065	0.084
H	-	4.5	-	0.177
J	1.0	1.4	0.040	0.055
K	10.8	11.0	0.426	0.433
L	4.7	5.3	0.185	0.209
M	0.4	0.8	0.016	0.031
N	1.5	2.49	0.087	0.102

Fig. 7 Transient thermal impedance junction to case.

① I_{FAVM} rating includes reverse blocking losses at $T_{vj} = 125^\circ\text{C}$, $V_R = 0.8 V_{RRM}$, duty cycle $d = 0.5$.

Data according to DIN/IEC 747.

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Fast Recovery Epitaxial Diodes (FRED)

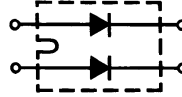
DSEI 2x61

$$I_{FAVM} = 2x60 \text{ A}$$

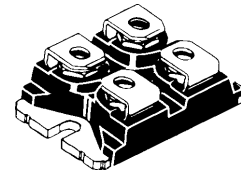
$$V_{RRM} = 1000 \text{ V}$$

$$t_{rr} = 35 \text{ ns}$$

V_{RSM}	V_{RRM}	Type
V	V	
1000	1000	DSEI 2x61-10B



miniBLOC, SOT-227 B



Symbol	Test Conditions	Maximum Ratings (per diode)	
I_{FRMS}	$T_{VJ} = T_{VJM}$	100	A
$I_{FAVM} \star$	$T_C = 50^\circ\text{C}$; rectangular, $d = 0.5$	60	A
I_{FRM}	$t_p < 10 \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	800	A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	500	A
		540	A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	450	A
		480	A
ji^2dt	$T_{VJ} = 45^\circ\text{C}$ $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	1150	A^2s
		1200	A^2s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	1000	A^2s
		950	A^2s
T_{VJ}		-40...+150	$^\circ\text{C}$
T_{VJM}		150	$^\circ\text{C}$
T_{stg}		-40...+150	$^\circ\text{C}$
P_{tot}	$T_C = 25^\circ\text{C}$	180	W
V_{ISOL}	50/60 Hz, RMS $I_{ISOL} \leq 1 \text{ mA}$	2500	V~
M_d	Mounting torque	1.5/13	Nm/lb.in.
	Terminal connection torque (M4)	1.5/13	Nm/lb.in.
Weight		30	g

Features

- International standard package miniBLOC (ISOTOP compatible)
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I_{RM} -values
- Soft recovery behaviour

Applications

- Antiparallel diode for high frequency switching devices
- Anti saturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating and melting
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Advantages

- High reliability circuit operation
- Low voltage peaks for reduced protection circuits
- Low noise switching
- Low losses
- Operating at lower temperature or space saving by reduced cooling

Symbol	Test Conditions	Characteristic Values (per diode)	
		typ.	max.
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$		3 mA
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		0.5 mA
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		14 mA
V_F	$I_F = 60 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$ $T_{VJ} = 25^\circ\text{C}$		1.8 V
			2.3 V
V_{T0}	For power-loss calculations only	1.43	V
r_T	$T_{VJ} = T_{VJM}$	6.1	m Ω
R_{thJC}		0.7	K/W
R_{thCK}		0.05	K/W
t_{rr}	$I_F = 1 \text{ A}$; $-di/dt = 200 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	35	50 ns
I_{RM}	$V_R = 540 \text{ V}$; $I_F = 60 \text{ A}$; $-di_F/dt = 480 \text{ A}/\mu\text{s}$ $L \leq 0.05 \mu\text{H}$; $T_{VJ} = 100^\circ\text{C}$	32	36 A

$\star I_{FAVM}$ rating includes reverse blocking losses at T_{VJM} , $V_R = 0.8 V_{RRM}$, duty cycle $d = 0.5$

Data according to DIN/IEC 747

IXYS reserves the right to change limits, test conditions and dimensions

96509A

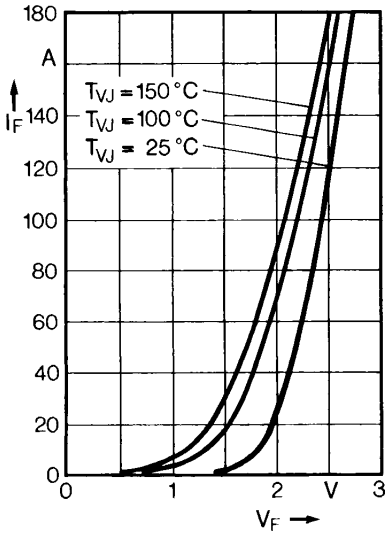


Fig. 1 Forward current versus voltage drop.

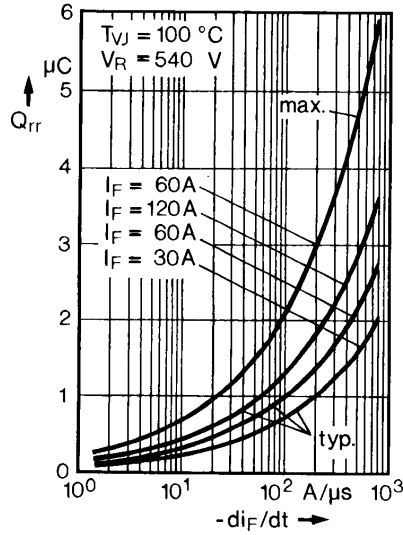


Fig. 2 Recovery charge versus $-di_F/dt$.

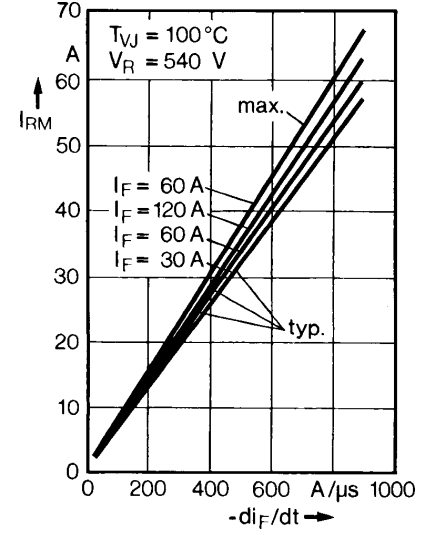


Fig. 3 Peak reverse current versus $-di_F/dt$.

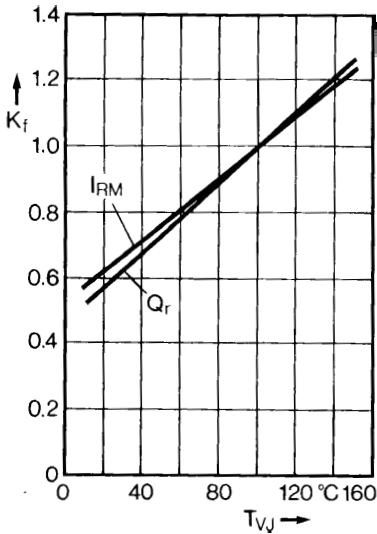


Fig. 4 Dynamic parameters versus junction temperature.

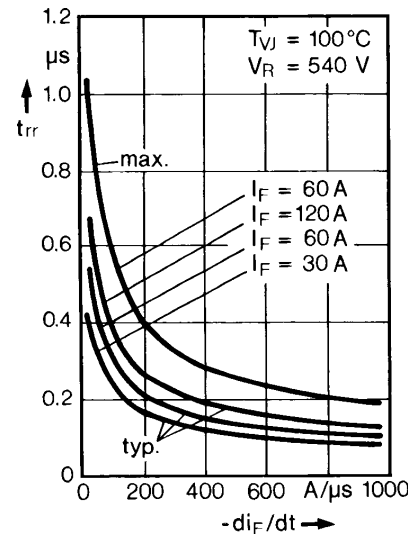


Fig. 5 Recovery time versus $-di_F/dt$.

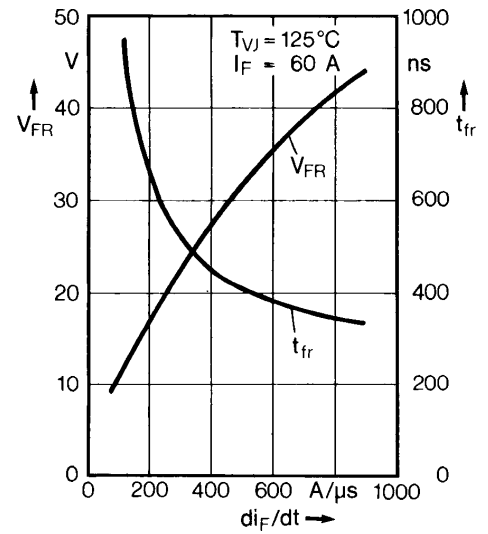


Fig. 6 Peak forward voltage versus $-di_F/dt$.

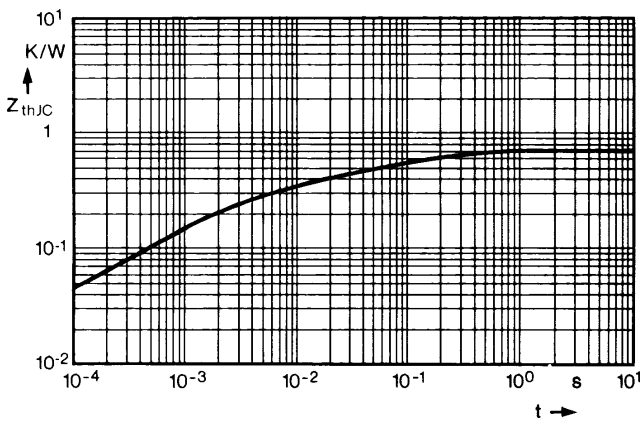
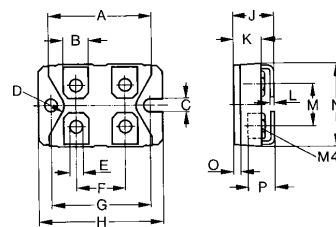


Fig. 7 Transient thermal impedance junction to case.

Dimensions



miniBLOC SOT-227 B
M4 screws (4x) supplied

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	31.5	31.7	1.241	1.249
B	7.8	8.2	0.307	0.323
C	4.0	-	0.158	-
D	4.1	4.3	0.162	0.169
E	4.1	4.3	0.162	0.169
F	14.9	15.1	0.587	0.595
G	30.1	30.3	1.186	1.193
H	38.0	38.2	1.497	1.505
J	11.8	12.2	0.465	0.481
K	8.9	9.1	0.351	0.359
L	0.75	0.85	0.030	0.033
M	12.6	12.8	0.496	0.504
N	25.2	25.4	0.993	1.001
O	1.95	2.05	0.077	0.081
P	-	5.0	-	0.197

Fast Recovery Epitaxial Diodes (FRED)

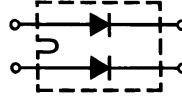
DSEI 2x61

$$I_{FAVM} = 2x52 \text{ A}$$

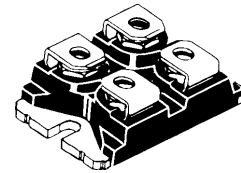
$$V_{RRM} = 1200 \text{ V}$$

$$t_{rr} = 40 \text{ ns}$$

V_{RSM}	V_{RRM}	Type
V	V	
1200	1200	DSEI 2x61-12B



miniBLOC, SOT-227 B



Symbol	Test Conditions	Maximum Ratings (per diode)	
I_{FRMS}	$T_{VJ} = T_{VJM}$	100	A
$I_{FAVM} \star$	$T_C = 50^\circ\text{C}$; rectangular, $d = 0.5$	52	A
I_{FRM}	$t_p < 10 \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	700	A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	450	A
		500	A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	400	A
		440	A
$\int i^2 dt$	$T_{VJ} = 45^\circ\text{C}$	1000	A^2s
		1050	A^2s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	800	A^2s
		810	A^2s
T_{VJ}		-40...+150	$^\circ\text{C}$
T_{VJM}		150	$^\circ\text{C}$
T_{stg}		-40...+150	$^\circ\text{C}$
P_{tot}	$T_C = 25^\circ\text{C}$	180	W
V_{ISOL}	50/60 Hz, RMS $I_{ISOL} \leq 1 \text{ mA}$	2500	V~
M_d	Mounting torque	1.5/13	Nm/lb.in.
	Terminal connection torque (M4)	1.5/13	Nm/lb.in.
Weight		30	g

Features

- International standard package miniBLOC (ISOTOP compatible)
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I_{RM} -values
- Soft recovery behaviour

Applications

- Antiparallel diode for high frequency switching devices
- Anti saturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating and melting
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Advantages

- High reliability circuit operation
- Low voltage peaks for reduced protection circuits
- Low noise switching
- Low losses
- Operating at lower temperature or space saving by reduced cooling

Symbol	Test Conditions	Characteristic Values (per diode)	
		typ.	max.
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$		2.2 mA
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		0.5 mA
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		14 mA
V_F	$I_F = 60 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$ $T_{VJ} = 25^\circ\text{C}$		2.15 V
			2.50 V
V_{T0}	For power-loss calculations only		1.65 V
r_T	$T_{VJ} = T_{VJM}$		8.3 m Ω
R_{thJC}		0.7	K/W
R_{thCK}		0.05	K/W
t_{rr}	$I_F = 1 \text{ A}$; $-di/dt = 200 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	40	60 ns
I_{RM}	$V_R = 540 \text{ V}$; $I_F = 60 \text{ A}$; $-di_F/dt = 480 \text{ A}/\mu\text{s}$ $L \leq 0.05 \mu\text{H}$; $T_{VJ} = 100^\circ\text{C}$	32	36 A

$\star I_{FAVM}$ rating includes reverse blocking losses at T_{VJM} , $V_R = 0.8 V_{RRM}$, duty cycle $d = 0.5$

Data according to DIN/IEC 747

IXYS reserves the right to change limits, test conditions and dimensions

96509A

Fig. 1 Forward current versus voltage drop.

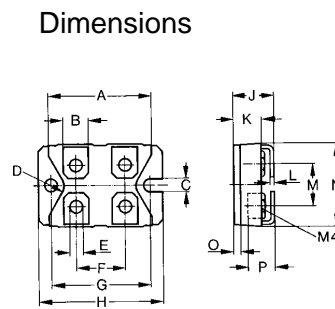
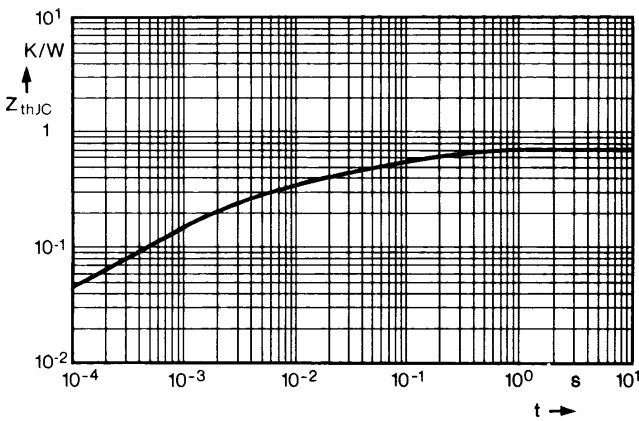
Fig. 2 Recovery charge versus $-di_F/dt$.

Fig. 3 Peak reverse current versus $-di_F/dt$.

Fig. 4 Dynamic parameters versus junction temperature.

Fig. 5 Recovery time versus $-di_F/dt$.

Fig. 6 Peak forward voltage versus $-di_F/dt$.



miniBLOC SOT-227 B
M4 screws (4x) supplied

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	31.5	31.7	1.241	1.249
B	7.8	8.2	0.307	0.323
C	4.0	-	0.158	-
D	4.1	4.3	0.162	0.169
E	4.1	4.3	0.162	0.169
F	14.9	15.1	0.587	0.595
G	30.1	30.3	1.186	1.193
H	38.0	38.2	1.497	1.505
J	11.8	12.2	0.465	0.481
K	8.9	9.1	0.351	0.359
L	0.75	0.85	0.030	0.033
M	12.6	12.8	0.496	0.504
N	25.2	25.4	0.993	1.001
O	1.95	2.05	0.077	0.081
P	-	5.0	-	0.197

Fig. 7 Transient thermal impedance junction to case.

Fast Recovery Epitaxial Diodes (FRED)

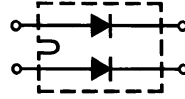
DSEI 2x121

$$I_{FAVM} = 2x123 \text{ A}$$

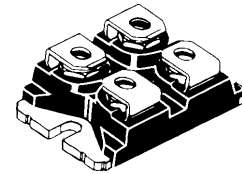
$$V_{RRM} = 200 \text{ V}$$

$$t_{rr} = 35 \text{ ns}$$

V_{RSM}	V_{RRM}	Type
V	V	
200	200	DSEI 2x121-02A



miniBLOC, SOT-227 B



Symbol	Test Conditions	Maximum Ratings (per diode)	
I_{FRMS}	$T_{VJ} = T_{VJM}$	150	A
$I_{FAVM} \star$	$T_C = 70^\circ\text{C}$; rectangular, $d = 0.5$	123	A
I_{FRM}	$t_p < 10 \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	600	A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	1200	A
		1300	A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	1080	A
		1170	A
ij^2dt	$T_{VJ} = 45^\circ\text{C}$ $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	7200	A^2s
		7100	A^2s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine $t = 8.3 \text{ ms}$ (60 Hz), sine	5800	A^2s
		5700	A^2s

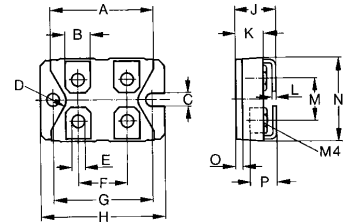
T_{VJ}	-40...+150	$^\circ\text{C}$
T_{VJM}	150	$^\circ\text{C}$
T_{stg}	-40...+150	$^\circ\text{C}$
P_{tot}	$T_C = 25^\circ\text{C}$	250 W
V_{ISOL}	50/60 Hz, RMS $I_{ISOL} \leq 1 \text{ mA}$	2500 V~
M_d	Mounting torque	1.5/13 Nm/lb.in.
	Terminal connection torque (M4)	1.5/13 Nm/lb.in.
Weight		30 g

Symbol	Test Conditions	Characteristic Values (per diode)	
		typ.	max.
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$		1 mA
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		0.5 mA
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		20 mA
V_F	$I_F = 120 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$ $T_{VJ} = 25^\circ\text{C}$	0.89	0.95 V
			1.10 V
V_{T0}	For power-loss calculations only		0.7 V
r_T	$T_{VJ} = T_{VJM}$		2.1 $\text{m}\Omega$
R_{thJC} R_{thCK}		0.1	0.5 K/W
			K/W
t_{rr}	$I_F = 1 \text{ A}$; $-di/dt = 400 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	35	50 ns
I_{RM}	$V_R = 100 \text{ V}$; $I_F = 100 \text{ A}$; $-di_F/dt = 200 \text{ A}/\mu\text{s}$ $L \leq 0.05 \mu\text{H}$; $T_{VJ} = 100^\circ\text{C}$	12	15 A

Features

- International standard package miniBLOC (ISOTOP compatible)
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I_{RM} -values
- Soft recovery behaviour

miniBLOC, SOT-227 B



M4 screws (4x) supplied

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	31.5	31.7	1.241	1.249
B	7.8	8.2	0.307	0.323
C	4.0	-	0.158	-
D	4.1	4.3	0.162	0.169
E	4.1	4.3	0.162	0.169
F	14.9	15.1	0.587	0.595
G	30.1	30.3	1.186	1.193
H	38.0	38.2	1.497	1.505
J	11.8	12.2	0.465	0.481
K	8.9	9.1	0.351	0.359
L	0.75	0.85	0.030	0.033
M	12.6	12.8	0.496	0.504
N	25.2	25.4	0.993	1.001
O	1.95	2.05	0.077	0.081
P	-	5.0	-	0.197

$\star I_{FAVM}$ rating includes reverse blocking losses at T_{VJM} , $V_R = 0.8 V_{RRM}$, duty cycle $d = 0.5$
Data according to DIN/IEC 747

IXYS reserves the right to change limits, test conditions and dimensions

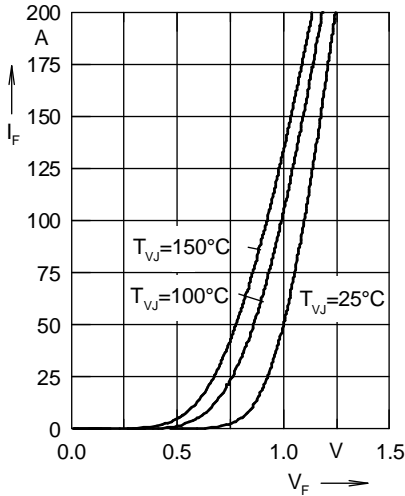


Fig. 1 Forward current I_F versus V_F

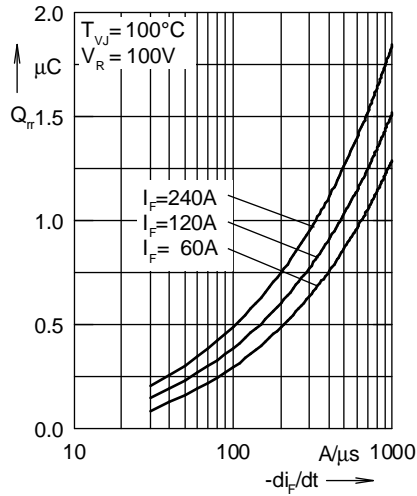


Fig. 2 Reverse recovery charge Q_{rr} versus $-di_F/dt$

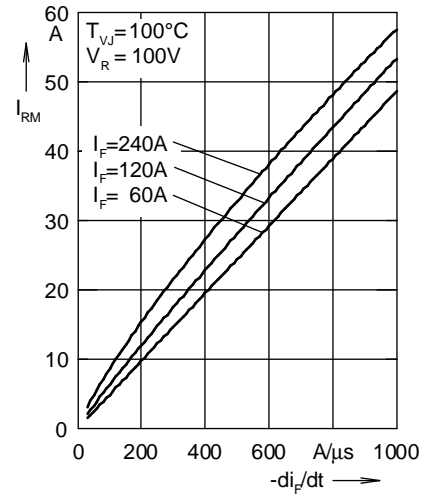


Fig. 3 Peak reverse current I_{RM} versus $-di_F/dt$

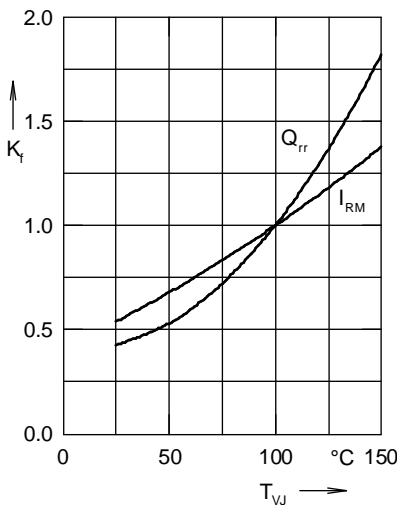


Fig. 4 Dynamic parameters Q_{rr} , I_{RM} versus T_{VJ}

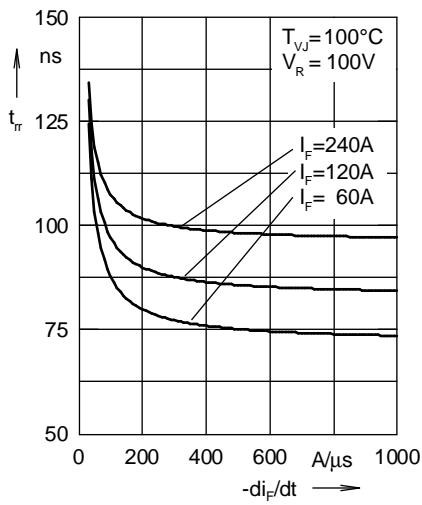


Fig. 5 Recovery time t_{rr} versus $-di_F/dt$

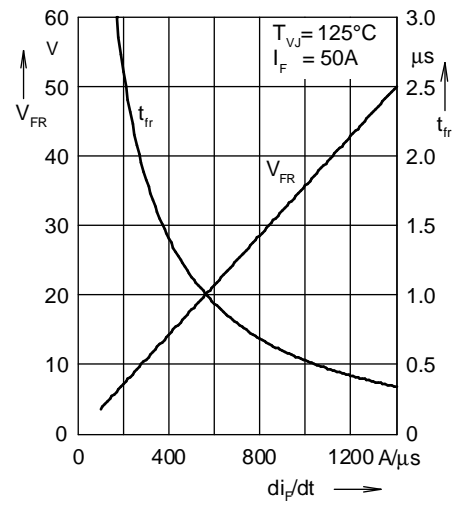


Fig. 6 Peak forward voltage V_{FR} and t_{rr} versus di_F/dt

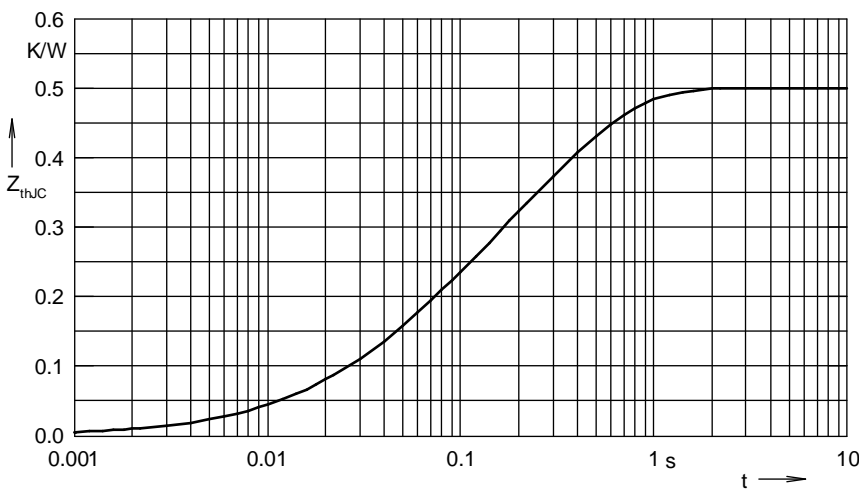


Fig. 7 Transient thermal impedance junction to case

Constants for Z_{thJS} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.109	0.028
2	0.214	0.092
3	0.429	0.35

Common Cathode Fast Recovery Epitaxial Diode (FRED)

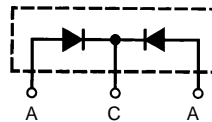
DSEK 30

$$I_{FAVM} = 2 \times 26 \text{ A}$$

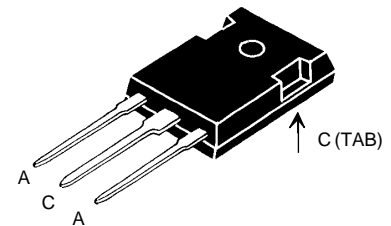
$$V_{RRM} = 1200 \text{ V}$$

$$t_{rr} = 40 \text{ ns}$$

V_{RSM}	V_{RRM}	Type
V	V	
1200	1200	DSEK 30-12A



TO-247 AD



A = Anode, C = Cathode, TAB = Cathode

Symbol	Test Conditions	Maximum Ratings	
I_{FRMS}	$T_{VJ} = T_{VJM}$	50	A
$I_{FAVM} \star$	$T_C = 85^\circ\text{C}$; rectangular, $d = 0.5$	26	A
I_{FRM}	$t_p < 10 \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	375	A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine	200	A
	$t = 8.3 \text{ ms}$ (60 Hz), sine	210	A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine	185	A
	$t = 8.3 \text{ ms}$ (60 Hz), sine	195	A
$\int i^2 dt$	$T_{VJ} = 45^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine	200	A^2s
	$t = 8.3 \text{ ms}$ (60 Hz), sine	180	A^2s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10 \text{ ms}$ (50 Hz), sine	170	A^2s
	$t = 8.3 \text{ ms}$ (60 Hz), sine	160	A^2s
T_{VJ}		-40...+150	$^\circ\text{C}$
T_{VJM}		150	$^\circ\text{C}$
T_{stg}		-40...+150	$^\circ\text{C}$
P_{tot}	$T_C = 25^\circ\text{C}$	125	W
M_d	Mounting torque with screw M3	0.45-0.55/4-5	Nm/lb.in.
	Mounting torque with screw M3.5	0.45-0.55/4-5	Nm/lb.in.
Weight		6	g

Features

- International standard package JEDEC TO-247 AD
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I_{RM} -values
- Soft recovery behavior
- Epoxy meets UL 94V-0 flammability classification

Applications

- Rectifiers in switch mode power supplies (SMPS)
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Advantages

- High reliability circuit operation
- Low voltage peaks for reduced protection circuits
- Low noise switching
- Low losses
- Operating at lower temperature or space saving by reduced cooling

Symbol	Test Conditions	Characteristic Values	
		typ.	max.
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$	750	μA
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$	250	μA
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$	7	mA
V_F	$I_F = 37 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$	2.2	V
	$T_{VJ} = 25^\circ\text{C}$	2.55	V
V_{T0}	For power-loss calculations only	1.65	V
r_T	$T_{VJ} = T_{VJM}$	18.2	m Ω
R_{thJC}		0.9	K/W
R_{thCK}		0.5	K/W
R_{thJA}		70	K/W
t_{rr}	$I_F = 1 \text{ A}$; $-di/dt = 100 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	40	60 ns
I_{RM}	$V_R = 540 \text{ V}$; $I_F = 30 \text{ A}$; $-di_F/dt = 240 \text{ A}/\mu\text{s}$	16	18 A
	$L \leq 0.05 \mu\text{H}$; $T_{VJ} = 100^\circ\text{C}$		

$\star I_{FAVM}$ rating includes reverse blocking losses at T_{VJM} , $V_R = 0.8 V_{RRM}$ duty cycle $d = 0.5$
Data according to DIN/IEC 747 and refer to a single diode unless otherwise stated.
IXYS reserves the right to change limits, test conditions and dimensions

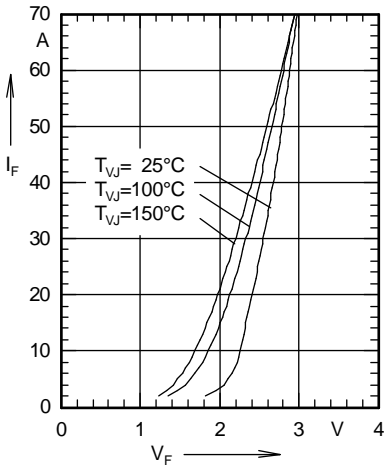


Fig. 1 Forward current versus voltage drop.

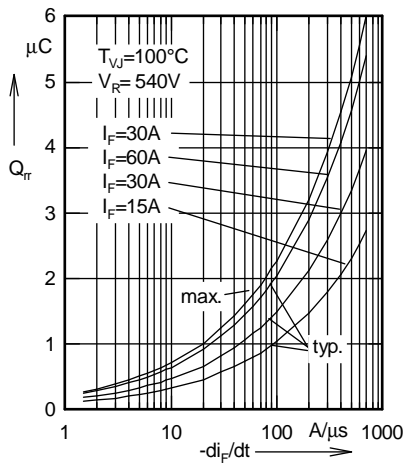


Fig. 2 Recovery charge versus $-di_F/dt$.

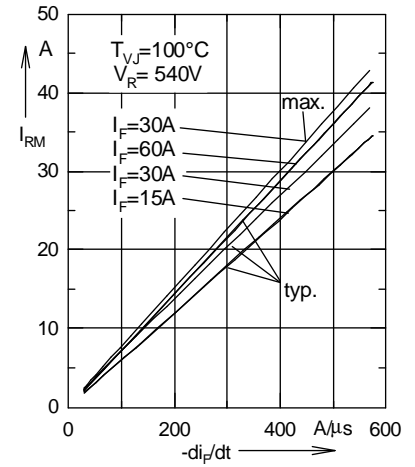


Fig. 3 Peak reverse current versus $-di_F/dt$.

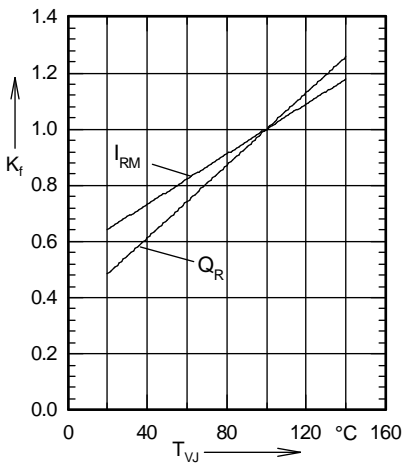


Fig. 4 Dynamic parameters versus junction temperature.

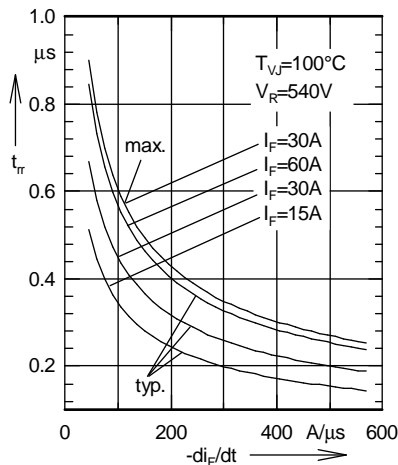


Fig. 5 Recovery time versus $-di_F/dt$.

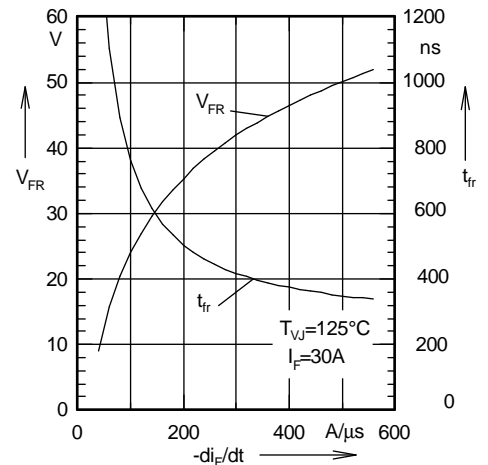


Fig. 6 Peak forward voltage versus $-di_F/dt$.

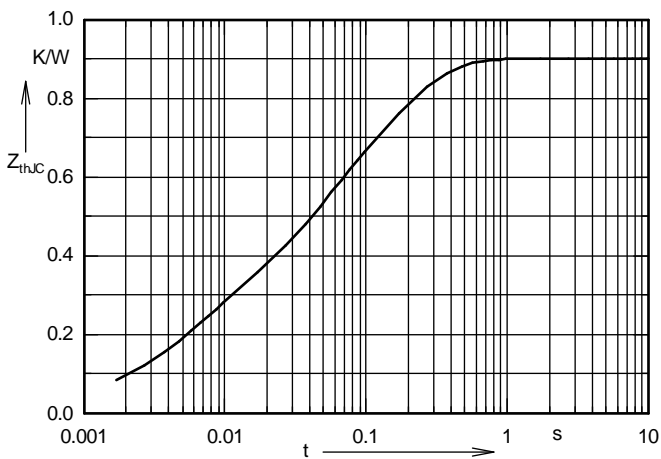
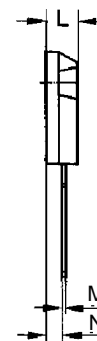
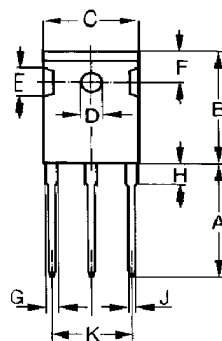


Fig. 7 Transient thermal impedance junction to case

Dimensions



Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	19.81	20.32	0.780	0.800
B	20.80	21.46	0.819	0.845
C	15.75	16.26	0.610	0.640
D	3.55	3.65	0.140	0.144
E	4.32	5.49	0.170	0.216
F	5.4	6.2	0.212	0.244
G	1.65	2.13	0.065	0.084
H	-	4.5	-	0.177
J	1.0	1.4	0.040	0.055
K	10.8	11.0	0.426	0.433
L	4.7	5.3	0.185	0.209
M	0.4	0.8	0.016	0.031
N	1.5	2.49	0.087	0.102